

Notice of References Cited

Application/Control No.

10/531,673

Applicant(s)/Patent Under

Reexamination

HWANG, SUK-HA

Examiner

Andrew Janca

Art Unit

1797

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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-1,382,765 A	06-1921	GRANT DIXON WALTER	366/163.1
*	B US-1,667,235 A	04-1928	Beattie, Robert	44/639
*	C US-2,144,178 A	01-1939	ERWIN BLUMNER	44/639
*	D US-3,627,275 A	12-1971	Gusmer, Frederick E.	366/146
*	E US-3,684,250 A	08-1972	Roeser, John O.	366/160.4
*	F US-3,733,183 A	05-1973	Singh, Alamjit D.	48/197FM
*	G US-3,877,682 A	04-1975	Moss, Lester I.	366/132
*	H US-3,897,939 A	08-1975	Hostettler et al.	366/132
*	I US-4,096,586 A	06-1978	Badertscher et al.	366/136
*	J US-4,224,039 A	09-1980	Smith et al.	44/551
*	K US-4,288,231 A	09-1981	Taylor, David W.	44/500
*	L US-4,302,111 A	11-1981	Harris, Hubert	366/107
*	M US-4,344,769 A	08-1982	Puff et al.	44/568

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 62179596 A	08-1987	Japan	NAGAHAMA et al.	C10L 01/32
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

*	U	
	V	
	W	
	X	

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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-4,407,431 A	10-1983	Hutter, III, Charles G.	222/1
*	B US-4,438,686 A	03-1984	Perez, Simon A.	99/353
*	C US-4,579,562 A	04-1986	Tarman et al.	48/197A
*	D US-4,646,771 A	03-1987	Prasad et al.	137/13
*	E US-4,668,244 A	05-1987	Nakamura et al.	44/591
*	F US-5,000,872 A	03-1991	Olah, Andrew M.	516/76
*	G US-5,248,393 A	09-1993	Schumacher et al.	202/158
*	H US-5,283,001 A	02-1994	Gregoli et al.	516/67
*	I US-5,344,231 A	09-1994	Jonsson et al.	366/137
*	J US-5,380,369 A	01-1995	Steinhauser et al.	134/1
*	K US-6,030,424 A	02-2000	Matsumoto, Setsuo	44/301
*	L US-6,190,461 B1	02-2001	Alack, Charles S.	127/22
*	M US-6,368,366 B1	04-2002	Langer et al.	44/301

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N				
*	O				
*	P				
*	Q				
*	R				
*	S				
*	T				

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1797

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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,485,632 B1	11-2002	Ward, Michael S.	208/179
*	B US-6,589,301 B1	07-2003	Magnin et al.	44/301
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

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